

Features

- Optimized package with separate driver source pin
- High blocking voltage with low on-resistance
- High-speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery (Q_{rr})
- Halogen free, RoHS compliant

V_{DS}	1200 V
$I_D @ 25^\circ C$	32 A
$R_{DS(on)}$	75 mΩ



Benefits

- Reduce switching losses and minimize gate ringing
- Higher system efficiency
- Reduce cooling requirements
- Increase power density
- Increase system switching frequency

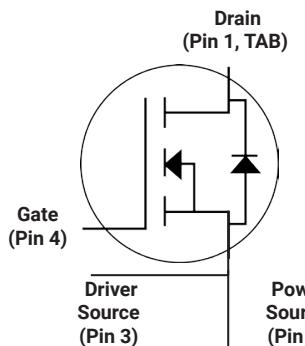
Applications

- Renewable energy
- EV battery chargers
- High voltage DC/DC converters
- Switch Mode Power Supplies



TO-247-4

Package



Maximum Ratings ($T_c = 25^\circ C$ unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note
V_{DSmax}	Drain - Source Voltage	1200	V	$V_{GS} = 0 \text{ V}$, $I_D = 100 \mu\text{A}$	
V_{GSmax}	Gate - Source Voltage (dynamic)	-8/+19	V	AC ($f > 1 \text{ Hz}$)	Note: 1
V_{GSop}	Gate - Source Voltage (static)	-4/+15	V	Static	Note: 2
I_D	Continuous Drain Current	32	A	$V_{GS} = 15 \text{ V}$, $T_c = 25^\circ \text{C}$	Fig. 19
		23		$V_{GS} = 15 \text{ V}$, $T_c = 100^\circ \text{C}$	
$I_{D(pulse)}$	Pulsed Drain Current	80	A	Pulse width t_p limited by T_{jmax}	Fig. 22
P_D	Power Dissipation	136	W	$T_c = 25^\circ \text{C}$, $T_j = 175^\circ \text{C}$	Fig. 20
T_j , T_{stg}	Operating Junction and Storage Temperature	-40 to +175	°C		
T_L	Solder Temperature	260	°C	1.6mm (0.063") from case for 10s	

Note (1): When using MOSFET Body Diode $V_{GSmax} = -4\text{V}/+19\text{V}$

Note (2): MOSFET can also safely operate at 0/+15 V

Electrical Characteristics ($T_c = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note		
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	1200			V	$V_{GS} = 0 \text{ V}, I_D = 100 \mu\text{A}$			
$V_{GS(\text{th})}$	Gate Threshold Voltage	1.8	2.5	3.6	V	$V_{DS} = V_{GS}, I_D = 5 \text{ mA}$	Fig. 11		
			2.2		V	$V_{DS} = V_{GS}, I_D = 5 \text{ mA}, T_J = 175^\circ\text{C}$			
I_{DSS}	Zero Gate Voltage Drain Current		1	50	μA	$V_{DS} = 1200 \text{ V}, V_{GS} = 0 \text{ V}$			
I_{GSS}	Gate-Source Leakage Current		10	250	nA	$V_{GS} = 15 \text{ V}, V_{DS} = 0 \text{ V}$			
$R_{DS(\text{on})}$	Drain-Source On-State Resistance		75	90	$\text{m}\Omega$	$V_{GS} = 15 \text{ V}, I_D = 20 \text{ A}$	Fig. 4, 5, 6		
			120			$V_{GS} = 15 \text{ V}, I_D = 20 \text{ A}, T_J = 175^\circ\text{C}$			
g_{fs}	Transconductance		12		S	$V_{DS} = 20 \text{ V}, I_{DS} = 20 \text{ A}$	Fig. 7		
			13			$V_{DS} = 20 \text{ V}, I_{DS} = 20 \text{ A}, T_J = 175^\circ\text{C}$			
C_{iss}	Input Capacitance		1390		pF	$V_{GS} = 0 \text{ V}, V_{DS} = 1000 \text{ V}$ $f = 1 \text{ MHz}$ $V_{AC} = 25 \text{ mV}$	Fig. 17, 18		
C_{oss}	Output Capacitance		58						
C_{rss}	Reverse Transfer Capacitance		2						
E_{oss}	C_{oss} Stored Energy		33		μJ	$V_{DS} = 800 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}, I_D = 20 \text{ A},$ $R_{G(\text{ext})} = 0 \Omega, L = 156 \mu\text{H}, T_J = 150^\circ\text{C}$	Fig. 16		
E_{ON}	Turn-On Switching Energy (Body Diode FWD)		270		μJ				
E_{OFF}	Turn-Off Switching Energy (Body Diode FWD)		77						
$t_{d(on)}$	Turn-On Delay Time		30		ns	$V_{DD} = 800 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}$ $I_D = 20 \text{ A}, R_{G(\text{ext})} = 0 \Omega,$ Timing relative to V_{DS} Inductive load	Fig. 27, 28		
t_r	Rise Time		14						
$t_{d(off)}$	Turn-Off Delay Time		38						
t_f	Fall Time		10						
$R_{G(\text{int})}$	Internal Gate Resistance		9.0		Ω	$f = 1 \text{ MHz}, V_{AC} = 25 \text{ mV}$			
Q_{gs}	Gate to Source Charge		17		nC	$V_{DS} = 800 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}$ $I_D = 20 \text{ A}$ Per IEC60747-8-4 pg 21	Fig. 12		
Q_{gd}	Gate to Drain Charge		18						
Q_g	Total Gate Charge		53						

Reverse Diode Characteristics ($T_c = 25^\circ\text{C}$ unless 1s otherwise specified)

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
V_{SD}	Diode Forward Voltage	4.5		V	$V_{GS} = -4 \text{ V}, I_{SD} = 10 \text{ A}$	Fig. 8, 9, 10
		4.0		V	$V_{GS} = -4 \text{ V}, I_{SD} = 10 \text{ A}, T_J = 175^\circ\text{C}$	
I_s	Continuous Diode Forward Current		26	A	$V_{GS} = -4 \text{ V}, T_J = 25^\circ\text{C}$	Note 1
$I_{s,pulse}$	Diode pulse Current	80		A	$V_{GS} = -4 \text{ V}, \text{pulse width } t_p \text{ limited by } T_{jmax}$	Note 1
t_{rr}	Reverse Recover time	20		ns	$V_{GS} = -4 \text{ V}, I_{SD} = 20 \text{ A}, V_R = 800 \text{ V}$ $dif/dt = 3600 \text{ A}/\mu\text{s}, T_J = 150^\circ\text{C}$	Note 1
Q_{rr}	Reverse Recovery Charge	254		nC		
I_{rrm}	Peak Reverse Recovery Current	18		A		

Thermal Characteristics

Symbol	Parameter	Max.	Unit	Test Conditions	Note
$R_{\theta JC}$	Thermal Resistance from Junction to Case	1.1	°C/W		Fig. 21
$R_{\theta JA}$	Thermal Resistance From Junction to Ambient	40			

Typical Performance

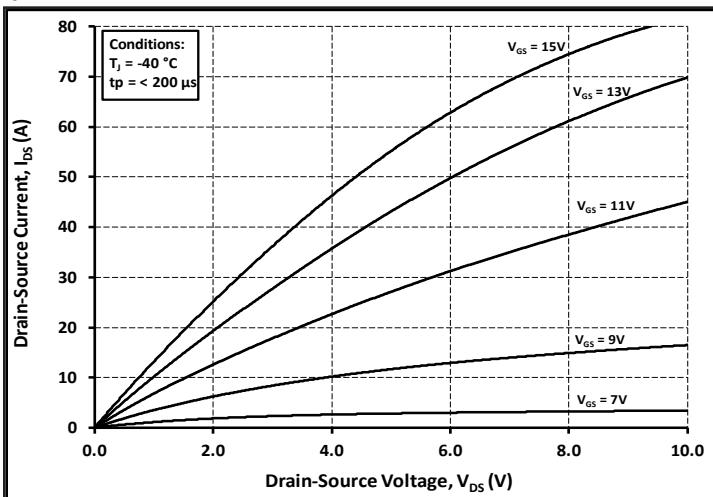


Figure 1. Output Characteristics $T_J = -40\text{ }^{\circ}\text{C}$

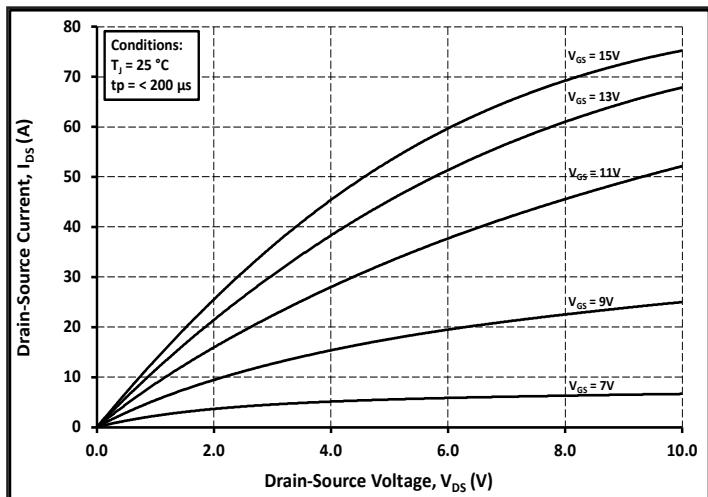


Figure 2. Output Characteristics $T_J = 25\text{ }^{\circ}\text{C}$

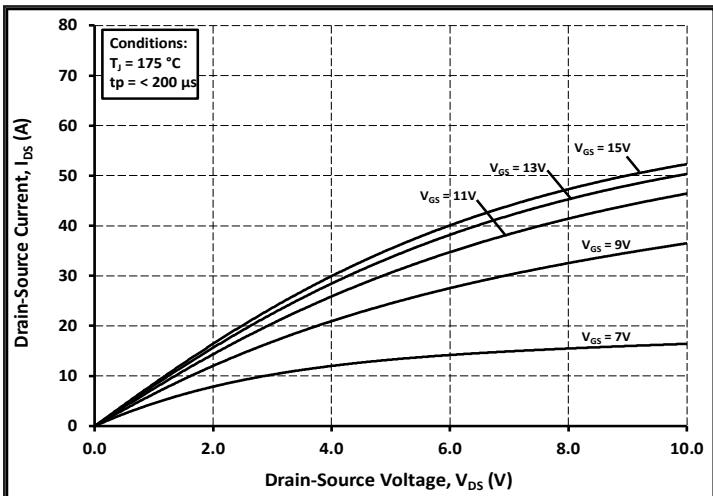


Figure 3. Output Characteristics $T_J = 175\text{ }^{\circ}\text{C}$

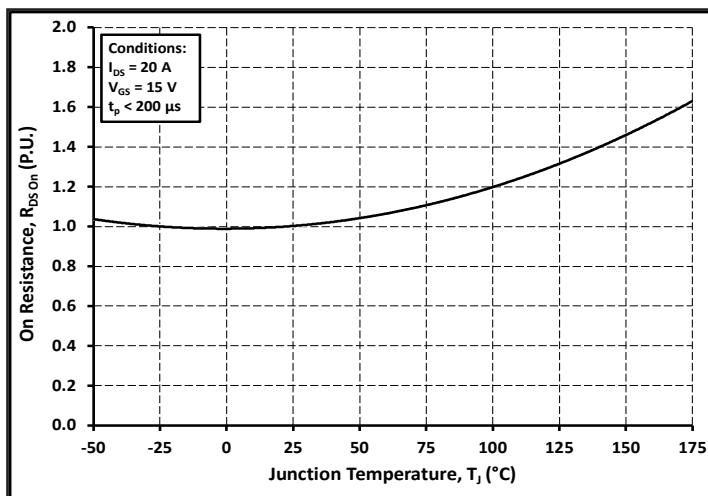


Figure 4. Normalized On-Resistance vs. Temperature

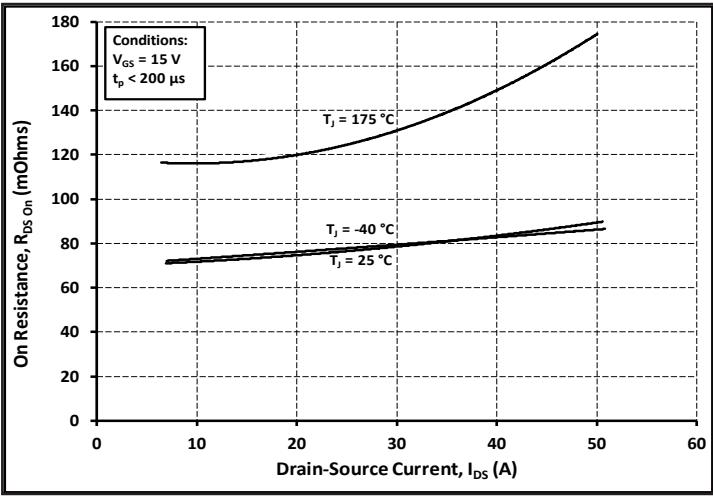


Figure 5. On-Resistance vs. Drain Current
For Various Temperatures

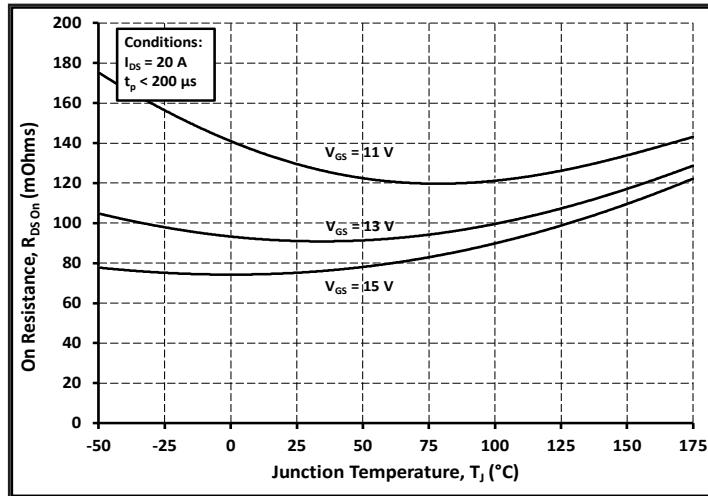


Figure 6. On-Resistance vs. Temperature
For Various Gate Voltage

Typical Performance

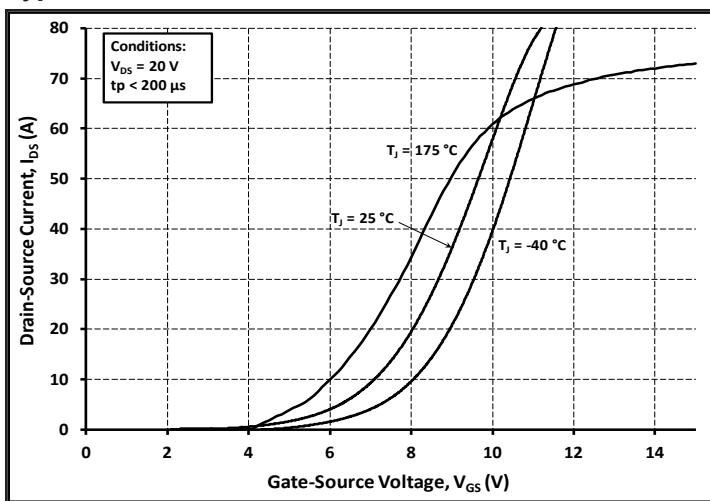


Figure 7. Transfer Characteristic for Various Junction Temperatures

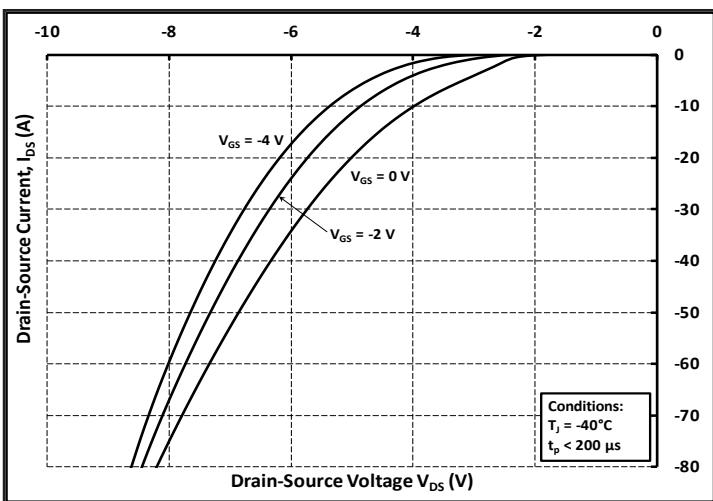


Figure 8. Body Diode Characteristic at -40°C

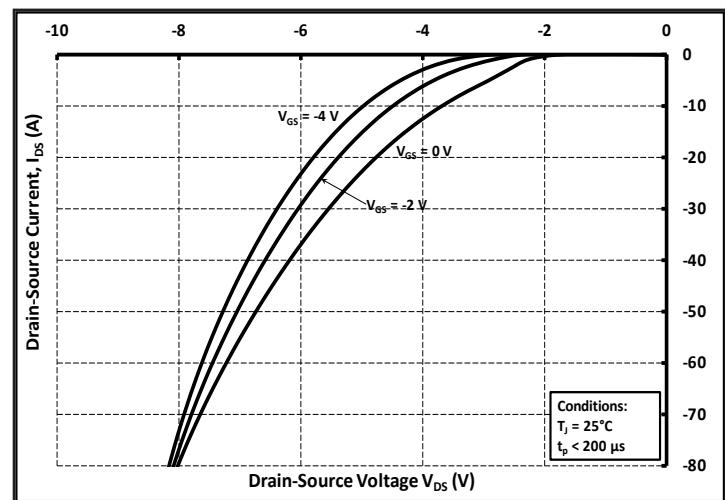


Figure 9. Body Diode Characteristic at 25°C

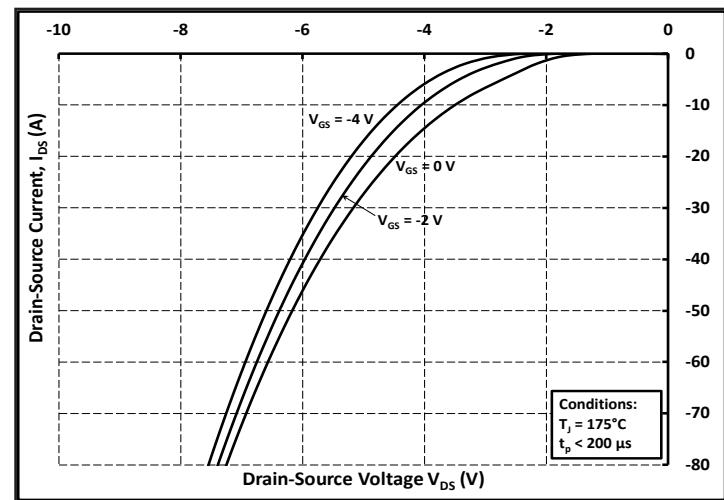


Figure 10. Body Diode Characteristic at 175°C

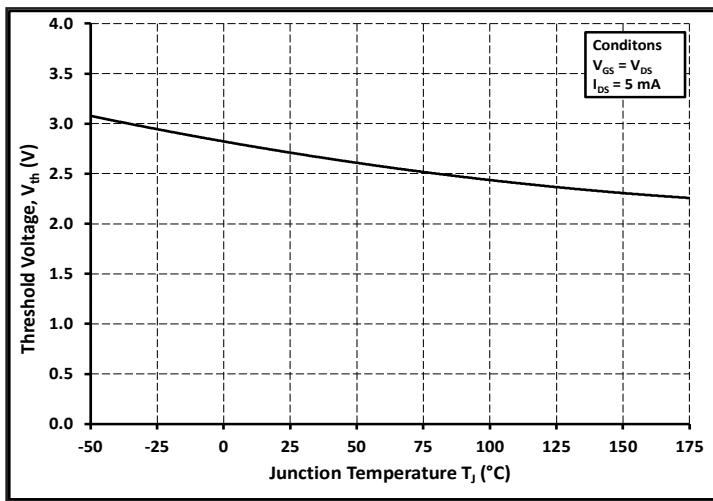


Figure 11. Threshold Voltage vs. Temperature

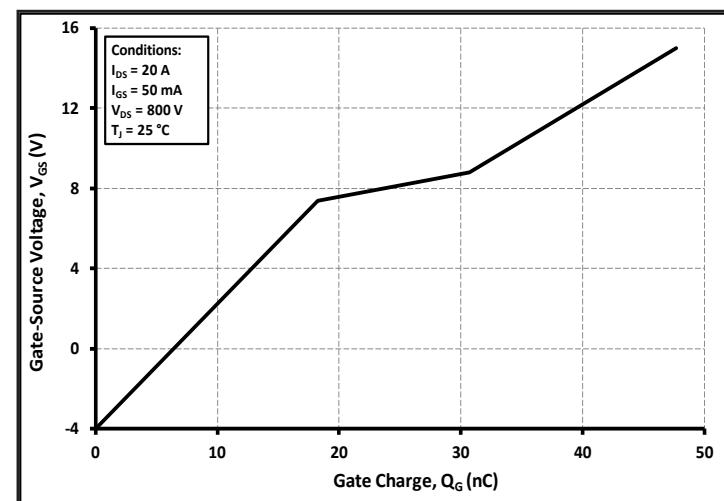


Figure 12. Gate Charge Characteristics

Typical Performance

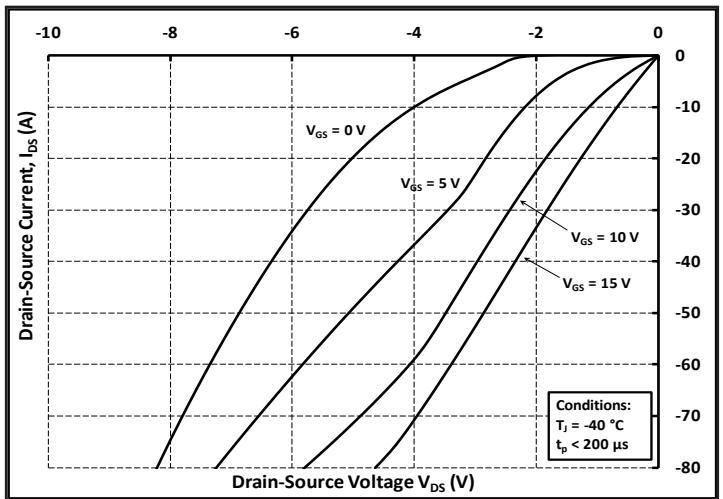


Figure 13. 3rd Quadrant Characteristic at $-40\text{ }^{\circ}\text{C}$

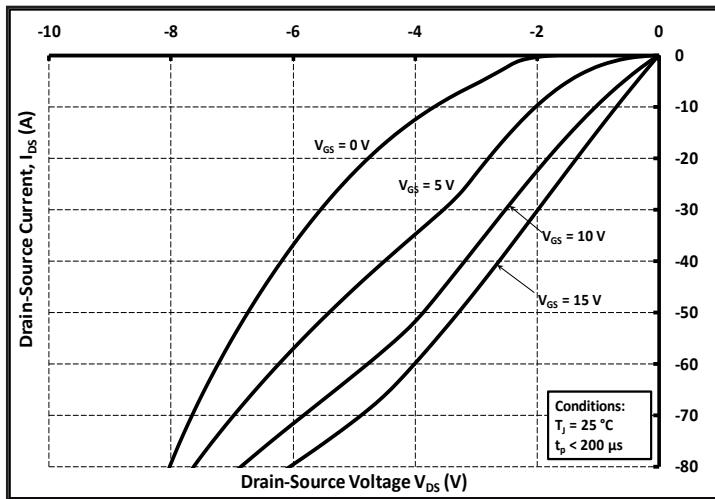


Figure 14. 3rd Quadrant Characteristic at $25\text{ }^{\circ}\text{C}$

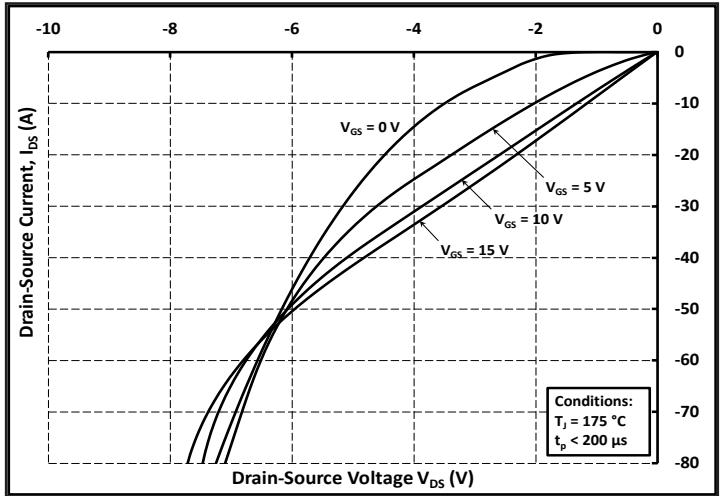


Figure 15. 3rd Quadrant Characteristic at $175\text{ }^{\circ}\text{C}$

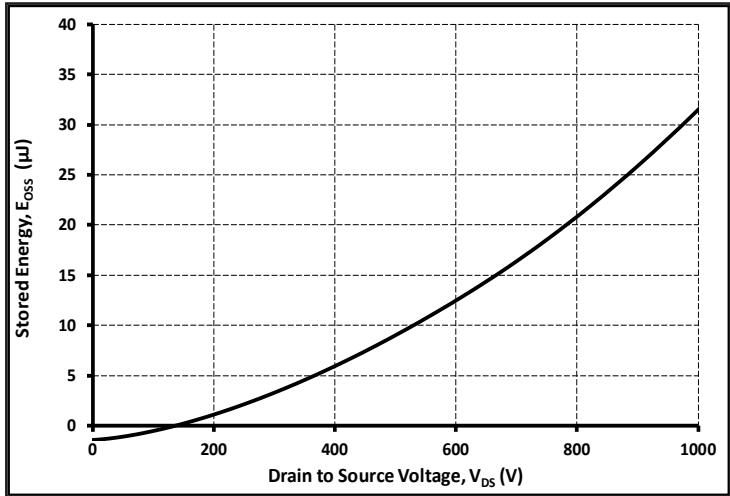


Figure 16. Output Capacitor Stored Energy

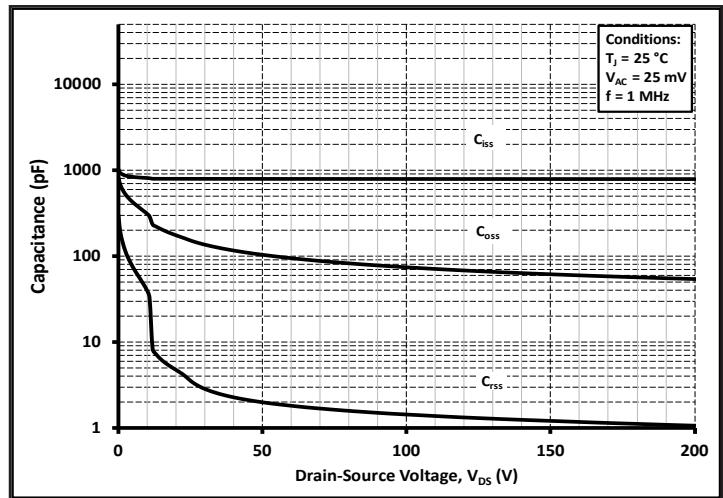


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)

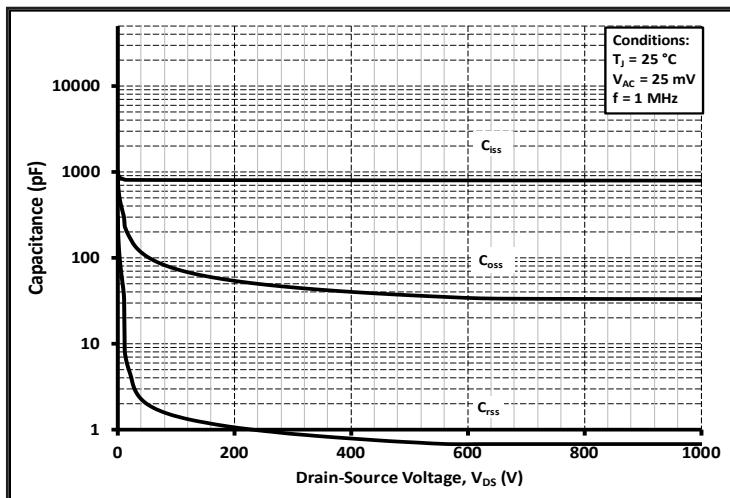


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 1000V)

Typical Performance

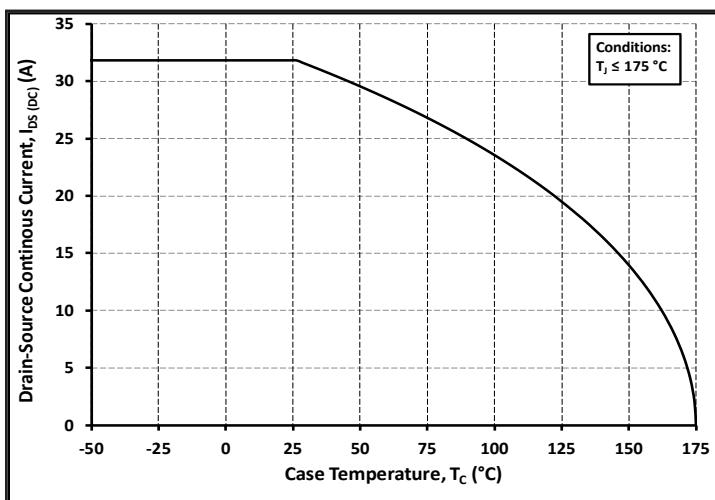


Figure 19. Continuous Drain Current Derating vs.
Case Temperature

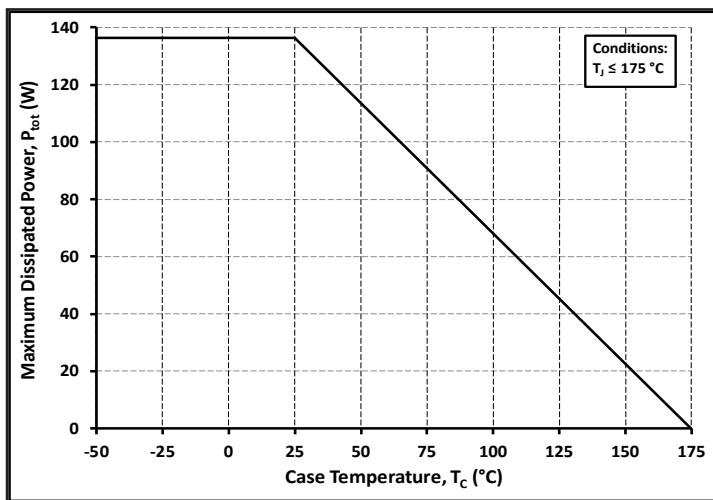


Figure 20. Maximum Power Dissipation Derating vs.
Case Temperature

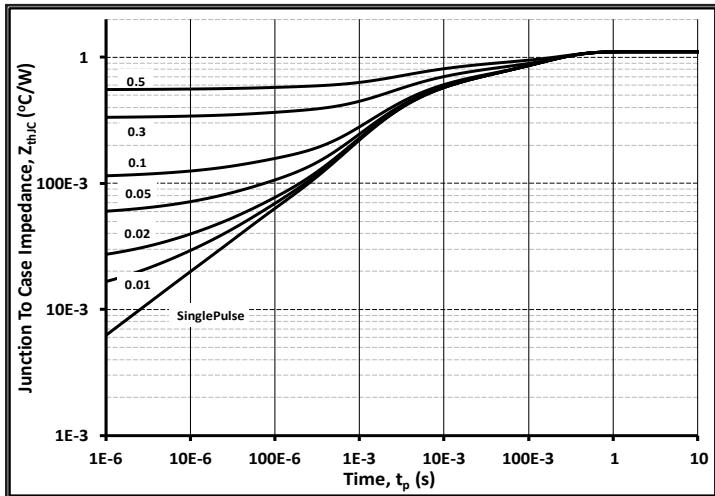


Figure 21. Transient Thermal Impedance
(Junction - Case)

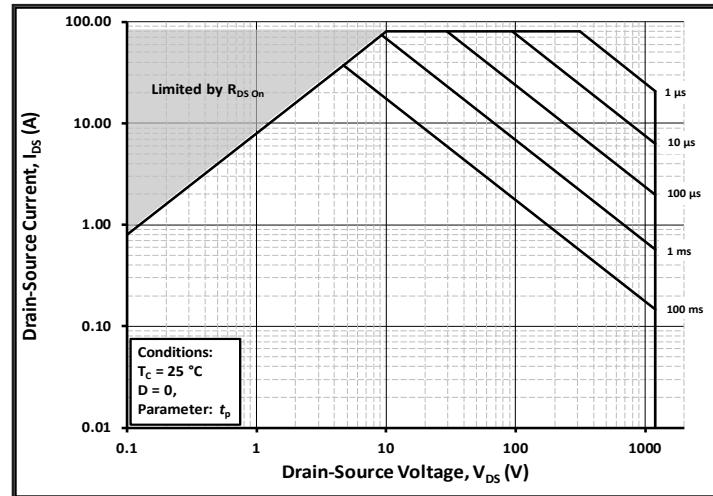


Figure 22. Safe Operating Area

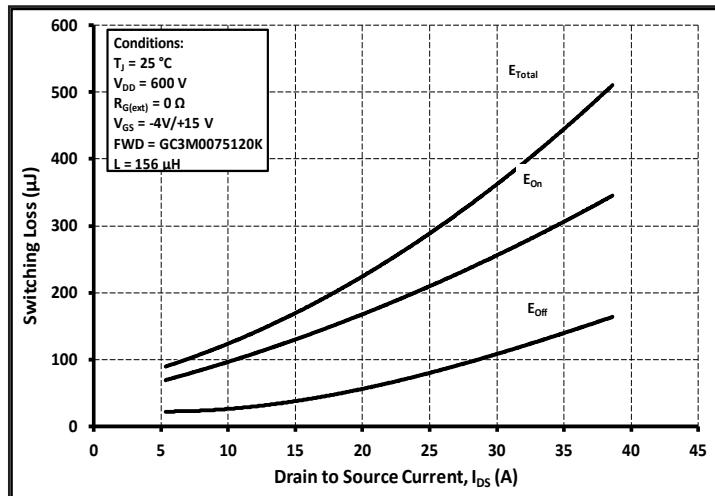


Figure 23. Clamped Inductive Switching Energy vs.
Drain Current ($V_{DD} = 600\text{V}$)

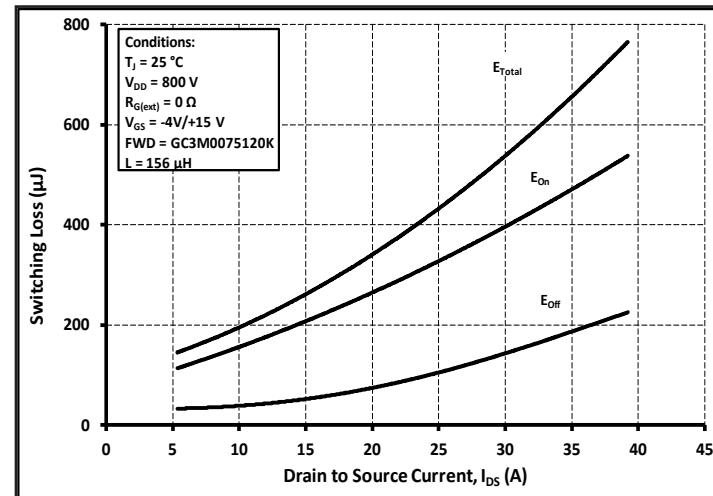


Figure 24. Clamped Inductive Switching Energy vs.
Drain Current ($V_{DD} = 800\text{V}$)

Typical Performance

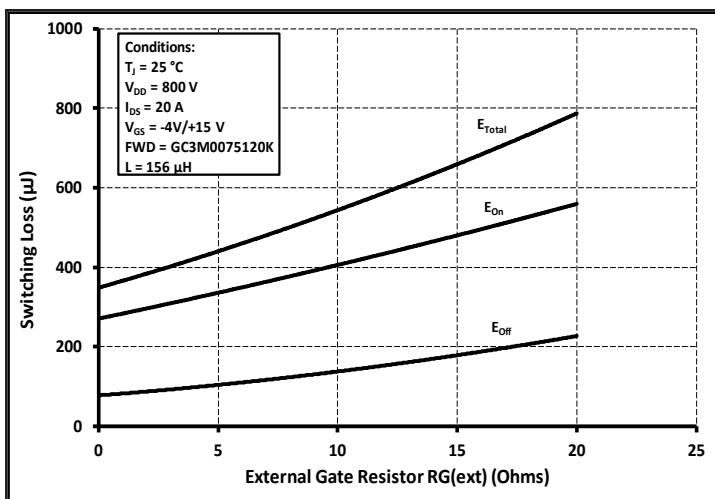


Figure 25. Clamped Inductive Switching Energy vs. $R_{G(\text{ext})}$

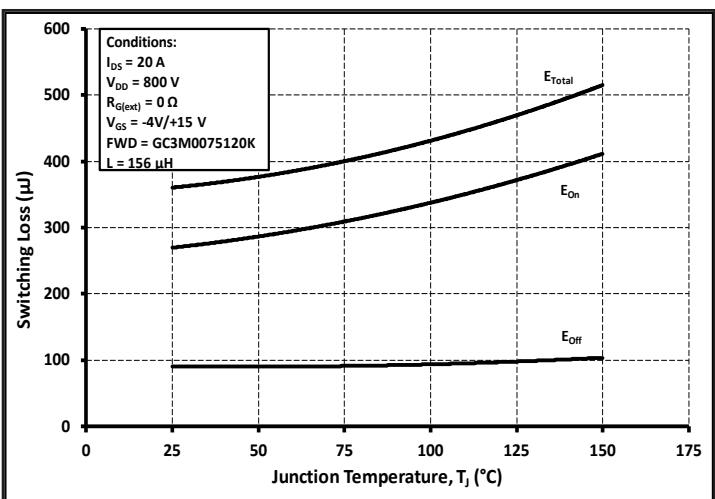


Figure 26. Clamped Inductive Switching Energy vs. Temperature

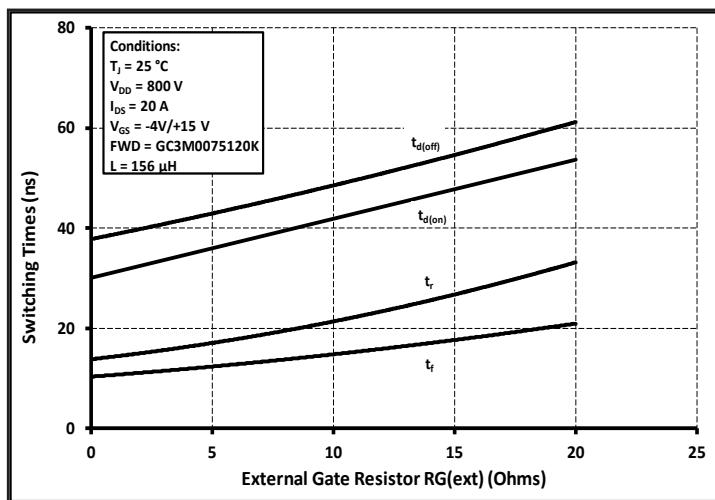


Figure 27. Switching Times vs. $R_{G(\text{ext})}$

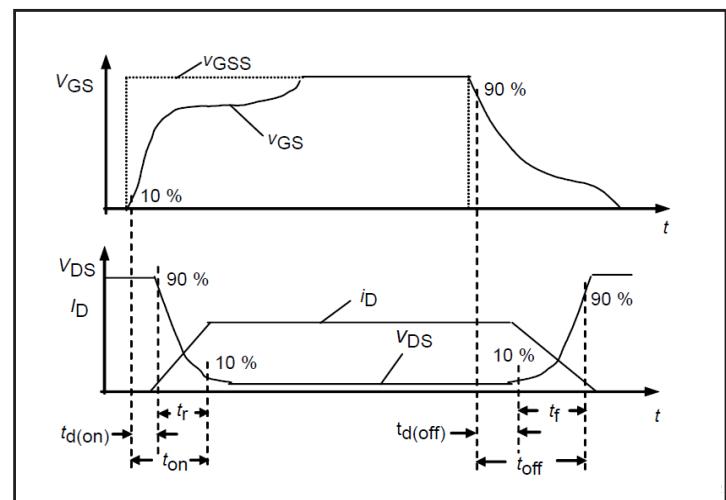


Figure 28. Switching Times Definition

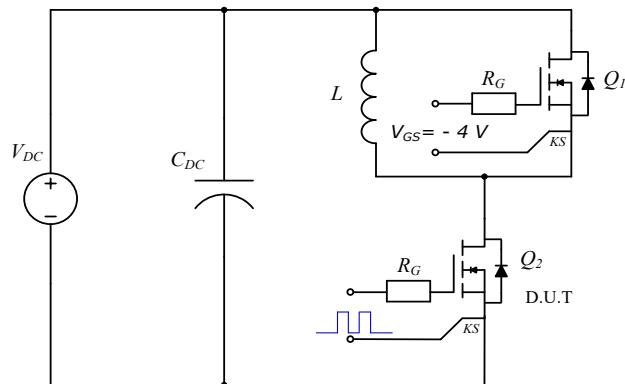
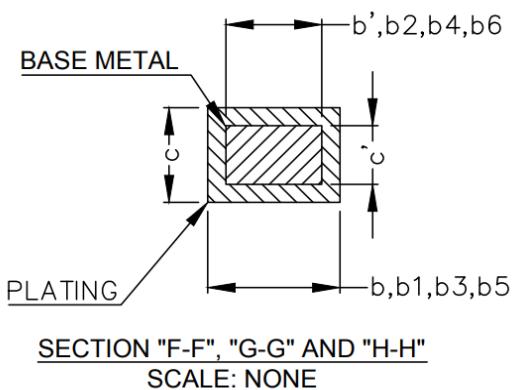
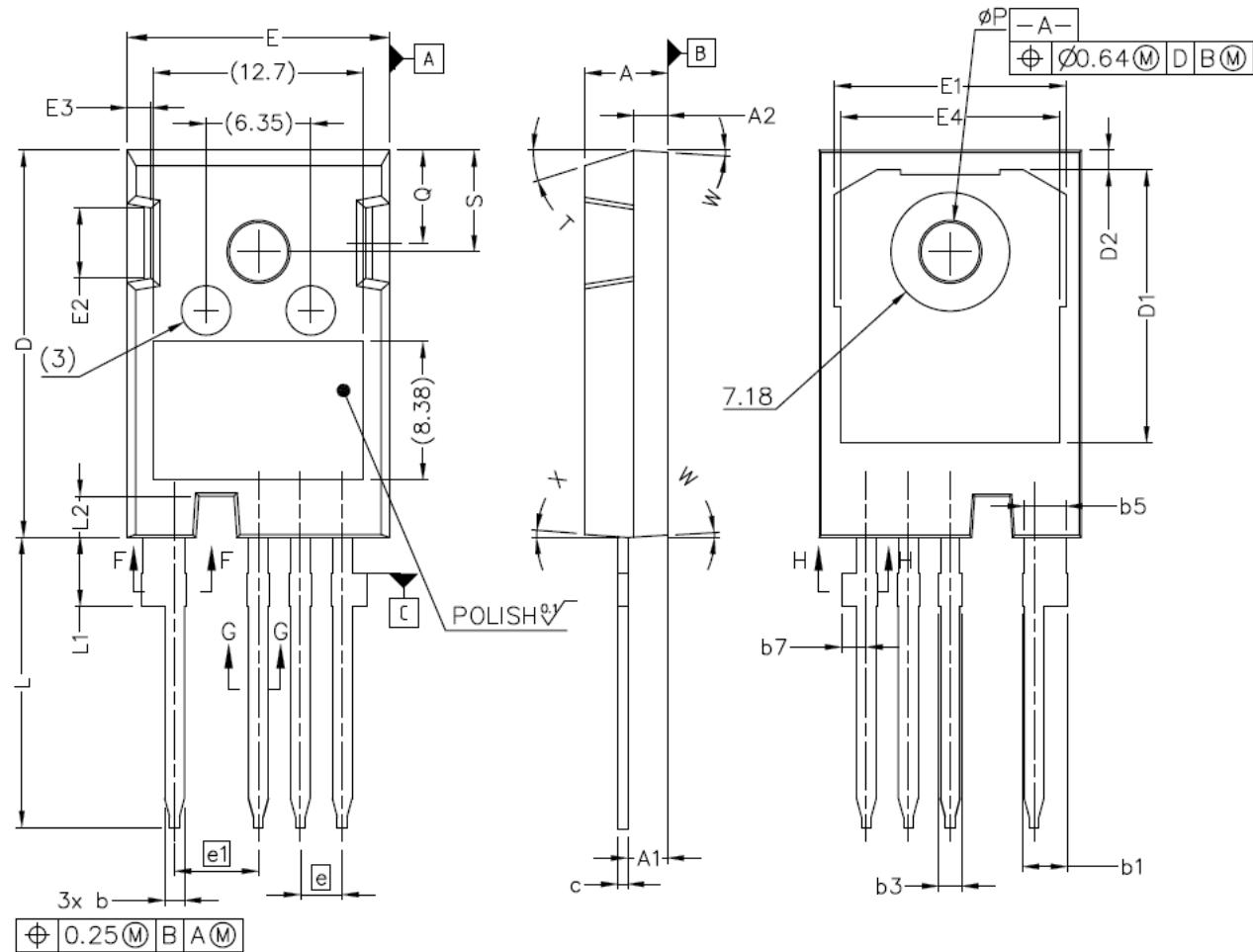
Test Circuit Schematic

Figure 29. Clamped Inductive Switching
Waveform Test Circuit

Note (3): Turn-off and Turn-on switching energy and timing values measured using SiC MOSFET Body Diode as shown above.

Package Dimensions

Package TO-247-4L

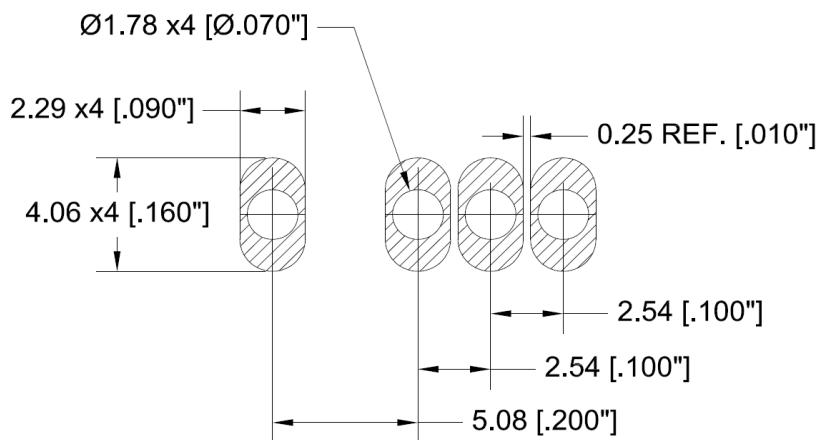


Package Dimensions

Package TO-247-4L

SYM	MILLIMETERS	
	MIN	MAX
A	4.83	5.21
A1	2.29	2.54
A2	1.91	2.16
b`	1.07	1.28
b	1.07	1.33
b1	2.39	2.94
b2	2.39	2.84
b3	1.07	1.60
b4	1.07	1.50
b5	2.39	2.69
b6	2.39	2.64
b7	1.30	1.70
c`	0.55	0.65
c	0.55	0.68
D	23.30	23.60
D1	16.25	17.65
D2	0.95	1.25
E	15.75	16.13

SYM	MILLIMETERS	
	MIN	MAX
E1	13.10	14.15
E2	3.68	5.10
E3	1.00	1.90
E4	12.38	13.43
e	2.54 BSC	
e1	5.08 BSC	
N*	4	
L	17.31	17.82
L1	3.97	4.37
L2	2.35	2.65
Ø P	3.51	3.65
Q	5.49	6.00
S	6.04	6.30
T	17.5° REF.	
W	3.5° REF.	
X	4° REF.	



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